# **High Speed Quad MOSFET Driver**

#### **Features**

- 6ns rise and fall time
- 2.0A peak output source/sink current
- ▶ 1.2V to 5.0V input CMOS compatible
- ▶ ±5.0V to ±9.0V supply voltage operation
- Smart Logic threshold
- Low jitter design
- Quad matched channels
- Drives two N and two P-channel MOSFETs
- Outputs can swing below ground
- Built-in level translator for negative gate bias
- Non-inverting gate driver OUTD for easy logic
- Low inductance quad flat no-lead package
- Thermally-enhanced package

### **Applications**

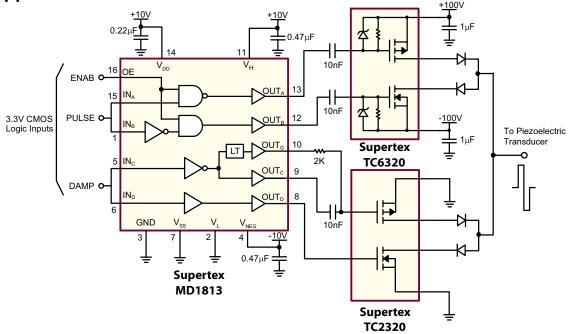
- Ultrasound PN code transmitter
- Medical ultrasound imaging
- Piezoelectric transducer drivers
- Nondestructive evaluation
- High speed level translator
- High voltage bipolar pulser

# **General Description**

The Supertex MD1813 is a high-speed quad MOSFET driver. It is designed to drive two N- and two P-channel, high voltage, DMOS FETs for medical ultrasound applications, but may be used in any application that needs a high output current for a capacitive load. The input stage of the MD1813 is a high-speed level translator that is able to operate from logic input signals of 1.2 to 5.0V amplitude. An adaptive threshold circuit is used to set the level translator threshold to the average of the input logic 0 and logic 1 levels. The level translator uses a proprietary circuit, which provides DC coupling together with high-speed operation.

The output stage of the MD1813 has separate power connections, enabling the output signal Land H levels to be chosen independently from the driver supply voltages. As an example, the input logic levels may be 0 and 1.8V, the control logic may be powered by +5.0 and -5.0V, and the output L and H levels may be varied anywhere over the range of -5.0 to +5.0V. The output stage is capable of peak currents of up to ±2.0 amps, depending on the supply voltages used and load capacitance. The OE pin serves a dual purpose. First, its logic H level is used to compute the threshold voltage level for the channel input level translators. Secondly, when OE is low, the outputs are disabled, with the A output high and the B output low. This assists in properly pre-charging the coupling capacitors that may be used in series in the gate drive circuit of an external PMOS and NMOS. A built-in level shifter is for PMOS gate negative bias driving. It enables the user-defined damping control to generate return-to-zero bipolar output pulses. The MD1813 has a non-inverting driver OUTD for easy logic.

# **Typical Application Circuit**



# **Ordering Information**

Device	16-Lead QFN 4x4mm body, 1.0mm height (max), 0.65mm pitch
MD1813	MD1813K6-G

<sup>-</sup>G indicates package is RoHS compliant ('Green')

# **Absolute Maximum Ratings**

Parameter	Value
V <sub>DD</sub> -V <sub>SS</sub> , Logic supply voltage	-0.5V to +13.5V
V <sub>H</sub> , Output high supply voltage	$V_L$ -0.5V to $V_{DD}$ +0.5V
V <sub>L</sub> , Output low supply voltage	$V_{ss}$ -0.5V to $V_{H}$ +0.5V
Vss, Low side supply voltage	-7.0V to +0.5V
$V_{\text{NEG}}$ - $V_{\text{SS}}$ , Negative supply voltage	$V_{ss}$ -10V to $V_{ss}$ +0.5V
Logic Input levels	V <sub>ss</sub> -0.5V to GND +7.0V
Maximum junction temperature	+125°C
Storage temperature	-65°C to 150°C
Soldering temperature	235°C
Package power dissipation	2.2W

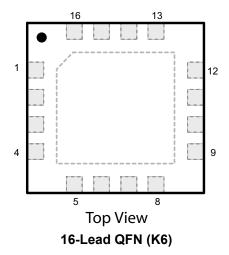
Absolute Maximum Ratings are those values beyond which damage to the device may occur. Functional operation under these conditions is not implied. Continuous operation of the device at the absolute rating level may affect device reliability. All voltages are referenced to device ground.







# **Pin Configuration**



## **Product Marking**



Y = Last Digit of Year Sealed W = Code for Week Sealed L = Lot Number \_\_\_\_ = "Green" Packaging

16-Lead QFN (K6)

#### **DC Electrical Characteristics**

 $(V_{H} = V_{DD} = 12V, V_{L} = V_{DS} = GND = 0V, V_{NEC} = -9.0V, V_{DE} = 3.3V, T_{L} = 25^{\circ}C)$ 

Sym	Parameter	Min	Тур	Max	Units	Conditions		
V <sub>DD</sub> -V <sub>SS</sub>	Logic supply voltage	4.5	-	13	V			
V <sub>ss</sub>	Low side supply voltage	-5.5	-	0	V			
V <sub>H</sub>	Output high supply voltage	V <sub>SS</sub> +2	-	V <sub>DD</sub>	V			
V <sub>L</sub>	Output low supply voltage	$V_{ss}$	-	V <sub>DD</sub> -2	V			
V <sub>NEG</sub>	Negative supply voltage	-13	-	V <sub>ss</sub> -2	V	May connect to VSS if OUTG not used		
I <sub>DDQ</sub>	V <sub>DD</sub> quiescent current	-	0.9	-	mA			
I <sub>HQ</sub>	V <sub>H</sub> quiescent current	-	-	10				
I <sub>NEGQ</sub>	V <sub>NEG</sub> quiescent current		150	-	μA			
I <sub>DD</sub>	V <sub>DD</sub> average current	-	8.0	-		$V_{H} = V_{DD} = 9.0V, V_{SS} = V_{LL} = GND = 0V,$		
I <sub>H</sub>	V <sub>H</sub> average current	-	22	-	mA	$V_{NEG} = -9.0V$ , One channel on at 5.0Mhz,		
I <sub>NEG</sub>	V <sub>NEG</sub> average current	-	1.0	-		No load		

# DC Electrical Characteristics (cont.)

 $(V_H = V_{DD} = 12V, \ V_L = V_{SS} = GND = 0V, \ V_{NEG} = -9.0V, \ V_{OE} = 3.3V, \ T_J = 25^{\circ}C)$ 

Sym	Parameter	Min	Тур	Max	Units	Conditions		
V <sub>IH</sub>	Input logic voltage high	V <sub>OE</sub> -0.3	-	5.0	V			
V <sub>IL</sub>	Input logic voltage low	0	-	0.3	\ \	For logic inputs INA, INB, INC, and IND		
I <sub>IH</sub>	Input logic current high	-	-	1.0		For logic inputs live, live, live, and live		
I <sub>IL</sub>	Input logic current low	-	-	1.0	μA			
V <sub>IH</sub>	OE Input logic voltage high	1.8	-	5.0	V			
V <sub>IL</sub>	OE Input logic voltage low	0	-	0.3	V	For logic input OE		
R <sub>IN</sub>	Input logic impedance to GND	12	20	30	ΚΩ			
C <sub>IN</sub>	Logic input capacitance	-	5.0	10	pF			

### **AC Electrical Characteristics**

 $(V_{_{H}} = V_{_{DD}} = 12V, \ V_{_{L}} = V_{_{\rm SS}} = GND = 0V, \ V_{_{NEG}} = -9.0V, \ V_{_{OE}} = 3.3V, \ T_{_{J}} = 25^{\circ}{\rm C})$ 

Sym	Parameter		Тур	Max	Units	Conditions		
t <sub>irf</sub>	Input or OE rise & fall time	-	-	10	ns	Logic input edge speed requirement		
t <sub>PLH</sub>	Propagation delay when output is from low to high	-	7.0	-		C <sub>LOAD</sub> = 1000pF, see timing diagram Input signal rise/fall time 2ns		
t <sub>PHL</sub>	Propagation delay when output is from high to low	-	7.0	-	ns			
t <sub>POE</sub>	Propagation delay OE to output	-	9.0	-				
t <sub>PCG</sub>	Propagation delay INC to OUTG	-	28	-				
t <sub>r</sub>	Output rise time	-	6.0	-				
t <sub>f</sub>	Output fall time	-	6.0	-				
t <sub>r</sub> - t <sub>r</sub>	Rise and fall time matching	-	1.0	-				
I t <sub>PLH</sub> -t <sub>PHL</sub> I	PHLI Propagation low to high and high to low matching		1.0	-	ns	for each channel		
$\Delta t_{\sf dm}$	Propagation delay matching	-	±2.0	-	ns	Device to device delay match		

# **Outputs**

 $(V_H = V_{DD}^- = 12V, V_L = V_{SS} = GND = 0V, V_{NEG} = -9.0V, V_{OE} = 3.3V, T_J = 25^{\circ}C)$ 

Sym	Parameter	Min	Тур	Max	Units	Conditions
R <sub>SINK</sub>	Output sink resistance	-	-	12.5	Ω	I <sub>SINK</sub> = 50mA
R <sub>SOURCE</sub>	Output source resistance	-	-	12.5	Ω	I <sub>SOURCE</sub> = 50mA
ISINK	Peak output sink current	-	2.0	-	Α	
SOURCE	Peak output source current	-	2.0	-	Α	

### **Application Information**

For proper operation of the MD1813, low inductance bypass capacitors should be used on the various supply pins. The GND pin should be connected to the logic ground. The INA, INB, INC, IND and OE pins should be connected to a logic source with a swing of GND to VCC, where VCC is 1.2 to 5.0 volts. Good trace practices should be followed corresponding to the desired operating speed. The internal circuitry of the MD1813 is capable of operating up to 100MHz, with the primary speed limitation being the loading effects of the load capacitance. Because of this speed and the high transient currents that result with capacitive loads, the bypass capacitors should be as close to the chip pins as possible. Unless the load specifically requires bipolar drive, the VSS, and VL pins should have low inductance feed-through connections directly to a ground plane. If these voltages are not zero, then they need bypass capacitors in a manner similar to the positive power supplies. The power connections VDD should have a ceramic bypass capacitor to the ground plane with short leads and decoupling components to prevent resonance in the power leads.

Output drivers, OUTA and OUTC, drive the gate of an external P-channel MOSFET, while output drivers OUTB and OUTD drive the gate of an external N-channel MOSFET, and they all swing from VH to VL. The auxiliary output drive, OUTG, swings from VSS to VNEG, and drives the external P-channel MOSFET as negative bias via a  $2K\Omega$  series resistor.

The voltages of VH and VL decide the output signal levels. These two pins can draw fast transient currents of up to 2.0A, so they should be provided with an appropriate bypass capacitor located next to the chip pins. A ceramic capacitor of up to 1.0µF may be appropriate, with a series ferrite bead

to prevent resonance in the power supply lead coming to the capacitor. Pay particular attention to minimizing trace lengths, current loop area, and using sufficient trace width to reduce inductance. Surface mount components are highly recommended. Since the output impedance of this driver is very low, in some cases it may be desirable to add a small series resistance in series with the output signal to obtain better waveform transitions at the load terminals. This will of course reduce the output voltage slew rate at the terminals of a capacitive load.

The OE pin sets the threshold level of logic for inputs ( $V_{OE} + V_{GND}$ ) / 2. When OE is low, OUTA is at VH. OUTB is at VL, regardless of the inputs INA or INB. This pin will not control OUTC, OUTD, or OUTG.

Pay particular attention that parasitic couplings are minimized from the output to the input signal terminals. The parasitic feedback may cause oscillations or spurious waveform shapes on the edges of signal transitions. Since the input operates with signals down to 1.2V, even small coupled voltages may cause problems. Use of a solid ground plane and good power and signal layout practices will prevent this problem. Be careful that a circulating ground return current from a capacitive load cannot react with common inductance to cause noise voltages in the input logic circuitry. Best timing performance is obtained for OUTC when the voltage of ( $V_{SS}$ - $V_{NEG}$ ) = ( $V_H$ - $V_L$ ).

When input logic is high, output will swing to VL, and when input logic is low, output will swing to VH. All inputs must be kept low until the device is powered up.

# **Logic Truth Table**

	Logic Inputs		Output					
OE	INA	INB	OU	OUTB				
Н	L	L	V	, н	V <sub>H</sub>			
Н	L	Н	V	, н	V <sub>L</sub>			
Н	Н	L	V	V <sub>H</sub>				
Н	Н	Н	V	V <sub>L</sub>				
L	X	X	V	V <sub>L</sub>				
OE*	INC	IND	OUTC	OUTG	OUTD**			
-	L	L	V <sub>H</sub>	V <sub>ss</sub>	V <sub>L</sub>			
-	L	Н	V <sub>H</sub>	$V_{_{\mathrm{SS}}}$	V <sub>H</sub>			
-	Н	L	V <sub>L</sub>	$V_{NEG}$	V <sub>L</sub>			
-	Н	Н	V <sub>L</sub>	$V_{NEG}$	V <sub>H</sub>			

#### Note:

# **Pin Description**

Pin #	Function	Description
1	INB	Logic input. Controls OUTB when OE is high.
2	VL	Supply voltage for N-channel output stage.
3	GND	Device ground.
4	VNEG	Supply voltage the auxiliary gate drive.
5	INC	Logic input. Controls OUTC when OE is high.
6	IND	Logic input. Controls OUTD when OE is high.
7	VSS	Supply voltage for low-side analog, level shifter, and gate drive circuit.
8	OUTD	Output driver.
9	OUTC	Output driver.
10	OUTG	Auxiliary output driver.
11	VH	Supply voltage for P-channel output stage
12	OUTB	Output driver.
13	OUTA	Output driver.
14	VDD	Supply voltage for high-side analog, level shifter, and gate drive circuit.
15	INA	Logic input. Controls OUTA when OE is high.
16	OE	Output enable logic input.

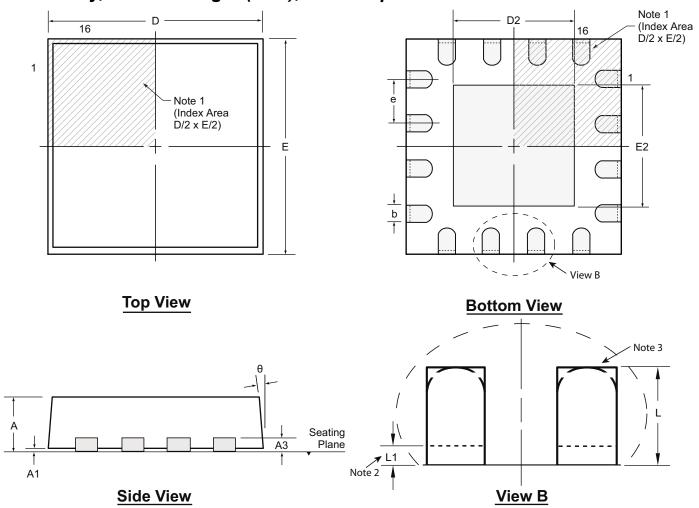
#### Note:

Thermal pad and pin #4, VNEG must be connected externally.

<sup>\*</sup> No control to OUTG , OUTC , or OUTD , \*\* OUTD is non-inverting output

# 16-Lead QFN Package Outline (K6)

# 4x4mm body, 1.00mm height (max), 0.65mm pitch



#### Notes:

- 1. Details of Pin 1 identifier are optional, but must be located within the indicated area. The Pin 1 identifier may be either a mold, or an embedded metal or marked feature.
- 2. Depending on the method of manufacturing, a maximum of 0.15mm pullback (L1) may be present.
- 3. The inner tip of the lead may be either rounded or square.

Symb	ol	Α	<b>A</b> 1	А3	b	D	D2	Е	E2	е	L	L1	θ
	MIN	0.80	0.00		0.25	3.85	2.50	3.85	2.50		0.30*	0.00	<b>0</b> °
Dimension (mm)	NOM	0.90	0.02	0.20 REF	0.30	4.00	2.65	4.00	2.65	0.65 BSC	0.40*	-	-
(11111)	MAX	1.00	0.05		0.35	4.15	2.80	4.15	2.80		0.50*	0.15	14º

JEDEC Registration MO-220, Variation VGGC-2, Issue K, June 2006.

Dimensions marked with (\*) are non-JEDEC dimensions. The value listed is for reference only. **Drawings not to scale.** 

(The package drawing(s) in this data sheet may not reflect the most current specifications. For the latest package outline information go to <a href="http://www.supertex.com/packaging.html">http://www.supertex.com/packaging.html</a>.)

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